

# MOSFET - Power, Single N-Channel 100 V, 4.3 mΩ, 113 A NTMFS4D2N10MD

#### **Features**

- Shielded Gate MOSFET Technology
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- Low Q<sub>RR</sub>, Soft Recovery Body Diode
- Low Qoss to Improve Light Load Efficiency
- These Devices are Pb-Free, Halogen Free/BFR Free, Beryllium Free and are RoHS Compliant

#### **Typical Applications**

- Primary Switch in Isolated DC-DC Converter
- Synchronous Rectification (SR) in DC-DC and AC-DC
- AC-DC Adapters (USB PD) SR
- Load Switch, Hotswap, and ORing Switch
- BLDC Motor and Solar Inverter

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter		Symbol	Value	Unit	
Drain-to-Source Voltage		$V_{DSS}$	100	V	
Gate-to-Source Voltage	9		V <sub>GS</sub>	±20	V
Continuous Drain Current R <sub>0JC</sub> (Note 1)	Steady	T <sub>C</sub> = 25°C	I <sub>D</sub>	113	Α
Power Dissipation $R_{\theta JC}$ (Note 1)	State		P <sub>D</sub>	132	V
Continuous Drain Current R <sub>θJA</sub> (Notes 1, 2)	Steady State	T <sub>A</sub> = 25°C	I <sub>D</sub>	16.4	Α
Power Dissipation R <sub>θJA</sub> (Notes 1, 2)	Glate		P <sub>D</sub>	2.8	W
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \ \mu s$		I <sub>DM</sub>	763	Α
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C	
Source Current (Body Diode)		I <sub>S</sub>	110	Α	
Single Pulse Drain-to-Source Avalanche Energy (I <sub>AV</sub> = 18 A) (Note 6)		E <sub>AS</sub>	486	mJ	
Lead Temperature Soldering Reflow for Soldering Purposes (1/8" from case for 10 s)		TL	300	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

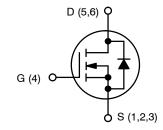
### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 1)	$R_{\theta JC}$	0.95	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	45	

The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

1

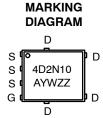
V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX	
100 V	4.3 mΩ @ 10 V	113 A	
100 V	7.1 mΩ @ 6 V	113 A	



**N-CHANNEL MOSFET** 



DFN5 (SO-8FL) CASE 488AA STYLE 1



A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

## **ORDERING INFORMATION**

Device	Package	Shipping†
NTMFS4D2N10MDT1G	DFN5 (Pb-Free)	1500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

<sup>2.</sup> Surface-mounted on FR4 board using 1  $\rm in^2$  pad size, 1 oz. Cu pad.

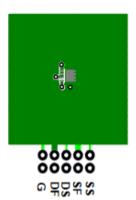
# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> =	= 250 μΑ	100			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /	I <sub>D</sub> = 250 μA, ref to 25°C			60		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C			1.0	μΑ
		$V_{DS} = 80 \text{ V}$	T <sub>J</sub> = 125°C			100	1
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{G}$	<sub>S</sub> = 20 V			100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D}$	= 239 µA	2		4	V
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>	I <sub>D</sub> = 239 μA, re	ef to 25°C		-7.9		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 46 A			3.8	4.3	mΩ
		V <sub>GS</sub> = 6 V, I <sub>E</sub>	<sub>)</sub> = 23 A		5.7	7.1	1
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> = 8 V, I <sub>D</sub>	<sub>)</sub> = 46 A		105		S
Gate-Resistance	$R_{G}$	T <sub>A</sub> = 25	°C		0.97	1.6	Ω
CHARGES & CAPACITANCES							•
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 50 V			3100		pF
Output Capacitance	Coss				800		1
Reverse Transfer Capacitance	C <sub>RSS</sub>				23		1
Output Charge	Q <sub>OSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 50 V			63.4		nC
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 6 V, V <sub>DS</sub> = 50 V, I <sub>D</sub> = 46 A			25		1
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 9	50 V, I <sub>D</sub> = 46 A		40	60	1
Threshold Gate Charge	Q <sub>G(TH)</sub>				10		1
Gate-to-Source Charge	Q <sub>GS</sub>				15		1
Gate-to-Drain Charge	$Q_{GD}$				6.7	10	1
Plateau Voltage	$V_{GP}$				5.0		V
SWITCHING CHARACTERISTICS (Note 3	3)						•
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS} = 10 \text{ V}, V_{D}$ $I_{D} = 46 \text{ A}, R_{O}$	<sub>OS</sub> = 50 V,		21		ns
Rise Time	t <sub>r</sub>	$I_D = 46 \text{ A}, R_C$	$_{\rm G} = 6  \Omega$		9.5		1
Turn-Off Delay Time	t <sub>d(OFF)</sub>				34		1
Fall Time	t <sub>f</sub>				6.5		1
DRAIN-SOURCE DIODE CHARACTERIS	STICS						
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C		0.85		٧
		$I_S = 46 \text{ A}$	T <sub>J</sub> = 125°C		0.73		1
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, } dI_S/dt = 0$			23.1		ns
Reverse Recovery Charge	Q <sub>RR</sub>	I <sub>S</sub> = 23	A		196		nC
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, dI}_{S}/\text{dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 46 \text{ A}$			52.6		ns
Reverse Recovery Charge	Q <sub>RR</sub>				66.1		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Switching characteristics are independent of operating junction temperatures

4. R<sub>θJA</sub> is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 × 1.5 in. board of FR-4 material. R<sub>θJC</sub> is guaranteed by design while R<sub>θCA</sub> is determined by the user's board design.



a) 45°C/W when mounted on a 1 in² pad of 2 oz copper.



b) 111°C/W when mounted on a minimum pad of 2 oz copper.

- 5. Pulse Test: pulse width < 300  $\mu$ s, duty cycle < 2%.
  6.  $E_{AS}$  of 486 mJ is based on started  $T_J$  = 25°C,  $I_{AS}$  = 18 A,  $V_{DD}$  = 90 V,  $V_{GS}$  = 15 V. 100% test at  $I_{AS}$  = 51.5 A.
  7. As an N-ch device, the negative Vgs rating is for low duty cycle pulse occurrence only. No continuous rating is implied.

#### **TYPICAL CHARACTERISTICS**

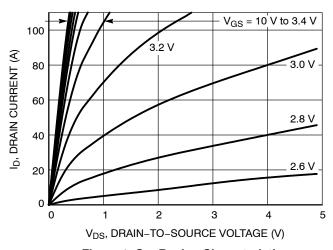


Figure 1. On-Region Characteristics

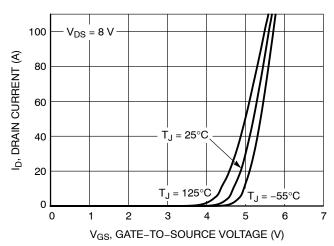


Figure 2. Transfer Characteristics

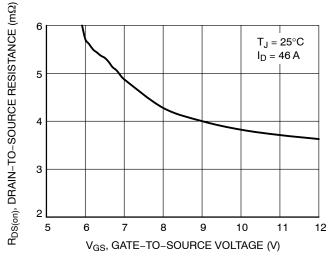


Figure 3. On-Resistance vs. Gate-to-Source Voltage

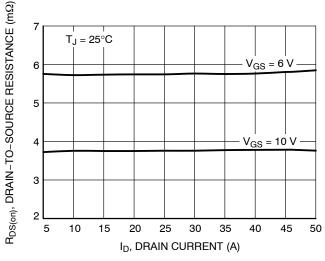
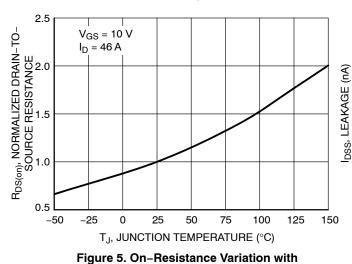


Figure 4. On-Resistance vs. Drain Current and Gate Voltage



Temperature

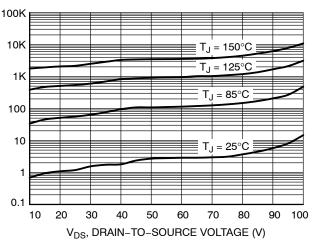
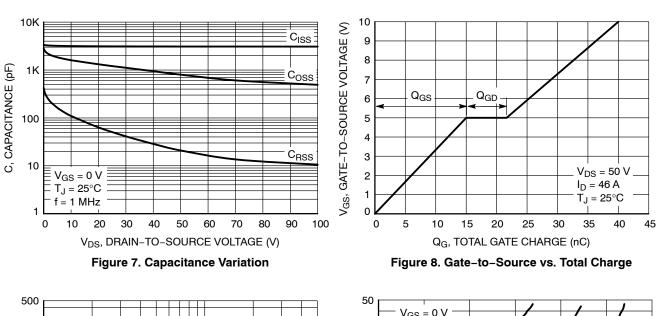
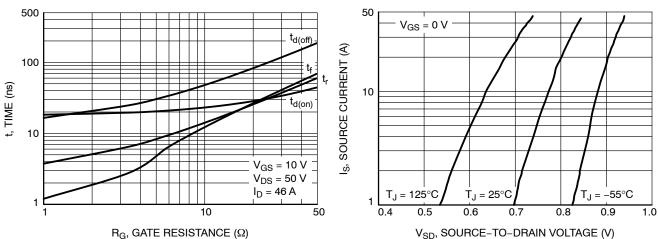


Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### **TYPICAL CHARACTERISTICS**







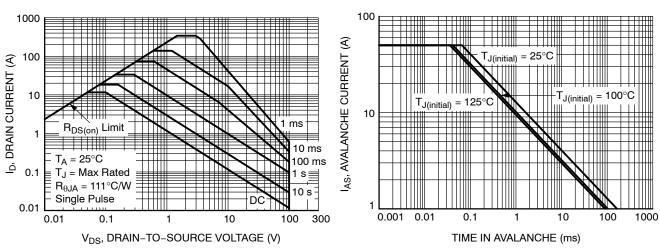


Figure 11. Maximum Rated Forward Biased Safe Operating Area

Figure 12. I<sub>PEAK</sub> vs. Time in Avalanche

Figure 10. Diode Forward Voltage vs. Current

### **TYPICAL CHARACTERISTICS**

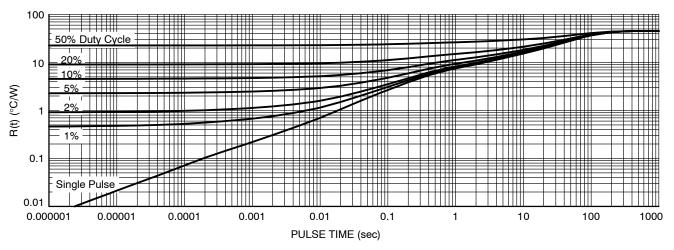


Figure 13. Thermal Characteristics

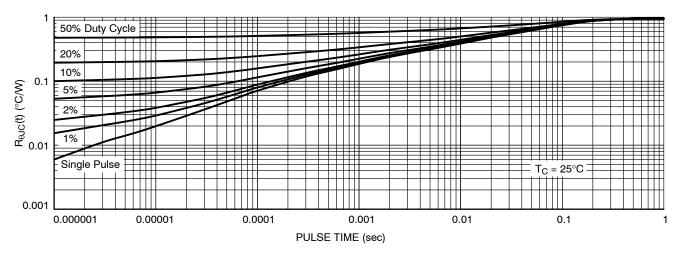


Figure 14. Thermal Characteristics





DFN5 5x6, 1.27P (SO-8FL) CASE 488AA **ISSUE N** 

**DATE 25 JUN 2018** 

#### NOTES:

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994.
  2. CONTROLLING DIMENSION: MILLIMETER.
  3. DIMENSION D1 AND E1 DO NOT INCLUDE
- MOLD FLASH PROTRUSIONS OR GATE BURRS

	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	0.90	1.00	1.10		
A1	0.00		0.05		
b	0.33	0.41	0.51		
С	0.23	0.28	0.33		
D	5.00	5.15	5.30		
D1	4.70	4.90	5.10		
D2	3.80	4.00	4.20		
E	6.00	6.15	6.30		
E1	5.70	5.90	6.10		
E2	3.45	3.65	3.85		
е	1.27 BSC				
G	0.51	0.575	0.71		
K	1.20	1.35	1.50		
L	0.51	0.575	0.71		
L1	0.125 REF				
М	3.00	3.40	3.80		
θ	0 °		12 °		

#### **GENERIC MARKING DIAGRAM\***



XXXXXX = Specific Device Code

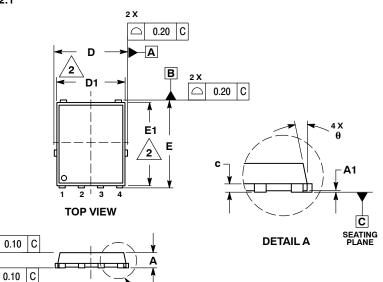
= Assembly Location Α

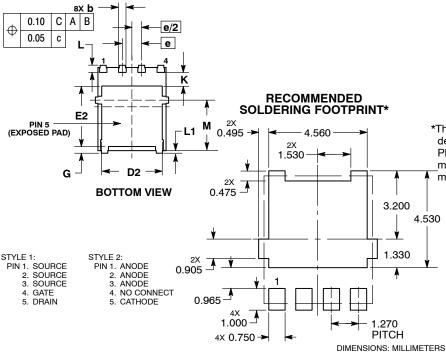
= Lot Traceability

Υ = Year W = Work Week

ZZ

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.





**DETAIL** A

SIDE VIEW

\*For additional information on our Pb-Free strategy and soldering details, please download the onsemi Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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